
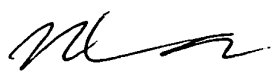


INFORMATION DISCLOSURE CITATION IN AN APPLICATION <div style="text-align: center;">  (PTO-1449) </div>		ATTY. DOCKET NO. 61282-017	SERIAL NO. 09/993,595
APPLICANT Kenji SHIMAZAKI, et al.		FILING DATE November 27, 2001	
GROUP 2858			

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EXAMINER 	DATE CONSIDERED 02/15/04
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.